Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/773,411	MAEDA, TAKESHI	
Examiner	Art Unit	
LaTanya Bibbins	2627	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Databases Searched: USPAT, USPGPub, EPO, JPO, DERWENT, (see search history attached)	11/11/2006	LB
Inventor Name Search	11/12/2006	LB
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